

INFORMATION DISCLOSURE STATEMENT

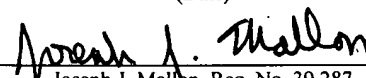
Applicant : Lin, et al.
App. No : 10/815,905
Filed : March 31, 2004
For : INTERFEROMETRIC MODULATION
PIXELS AND MANUFACTURING
METHOD THEREOF
Examiner : Unassigned
Art Unit : 2871

CERTIFICATE OF MAILING

I hereby certify that this correspondence and all marked attachments are being deposited with the United States Postal Service as first-class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on

September 6, 2006

(Date)


Joseph J. Mallon, Reg. No. 39,287

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

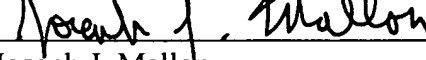
Enclosed for filing in the above-identified application is a PTO/SB/08 Equivalent listing 547 references to be considered by the Examiner. Also enclosed are 128 foreign patent references and/or non-patent literature as listed on the Information Disclosure Statement.

This Information Disclosure Statement is being filed before the receipt of a first Office Action on the merits, and presumably no fee is required. If a first Office Action on the merits was mailed before the mailing date of this Statement, the Commissioner is authorized to charge the fee set forth in 37 C.F.R. § 1.17(p) to Deposit Account No. 11-1410.

Respectfully submitted,

KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated: 9/6/06

By: 
Joseph J. Mallon
Registration No. 39,287
Attorney of Record
Customer No. 59,747
(619) 235-8550

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Multiple sheets used when necessary)

SEP 08 2006

SHEET 1 OF 22

Application No.	10/815,905
Filing Date	March 31, 2004
First Named Inventor	Lin, et al.
Art Unit	2871
Examiner	Unassigned
Attorney Docket No.	QCO.094A/061113

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1.	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	1	2,534,846	12/19/50	Ambrose et al.	
	2	3,439,973	04/22/69	Paul et al.	
	3	3,443,854	05/13/69	Weiss	
	4	3,616,312	10-26-1971	McGriff, et al.	
	5	3,653,741	04/04/72	Marks	
	6	3,656,836	04/18/72	de Cremoux et al.	
	7	3,725,868	04/03/73	Malmer, Jr. et al.	
	8	3,813,265	05/28/74	Marks	
	9	3,955,880	05/11/76	Lierke	
	10	4,099,854	07/11/78	Decker et al.	
	11	4,196,396	04/01/80	Smith	
	12	4,228,437	10/14/80	Shelton	
	13	4,377,324	03/22/83	Durand et al.	
	14	4,389,096	06/21/83	Hori et al.	
	15	4,392,711	07-12-1983	Moraw, et al.	
	16	4,403,248	09/06/83	te Velde	
	17	4,441,791	04/10/84	Hornbeck	
	18	4,445,050	04/24/84	Marks	
	19	4,459,182	07/10/84	te Velde	
	20	4,482,213	11/13/84	Piliavin et al.	
	21	4,500,171	02/19/85	Penz et al.	
	22	4,519,676	05/28/85	te Velde	
	23	4,531,126	07/23/85	Sadones	
	24	4,566,935	01/28/86	Hornbeck	
	25	4,571,603	02/18/86	Hornbeck et al.	
	26	4,596,992	06/24/86	Hornbeck	
	27	4,615,595	10/07/86	Hornbeck	
	28	4,617,608	10-14-1986	Blonder, et al.	

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U.S. PATENT DOCUMENTS

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	29	4,662,746	05/05/87	Hornbeck	
	30	4,663,083	05/05/87	Marks	
	31	4,681,403	07/21/87	te Velde et al.	
	32	4,710,732	12/01/87	Hornbeck	
	33	4,748,366	05/31/88	Taylor	
	34	4,786,128	11/22/88	Birnback	
	35	4,790,635	12/13/88	Apsley	
	36	4,856,863	08/15/89	Sampsell et al.	
	37	4,859,060	08-22-1989	Kitagirinet al	
	38	4,900,136	02/13/1990	Goldburt et al.	
	39	4,900,395	02/13/1990	Syverson et al.	
	40	4,937,496	06/26/90	Neiger et al.	
	41	4,954,789	09/04/90	Sampsell	
	42	4,956,619	09/11/90	Hornbeck	
	43	4,965,562	10/23/1990	Verhulst	
	44	4,982,184	01/01/91	Kirkwood	
	45	5,018,256	05/28/91	Hornbeck	
	46	5,022,745	06/11/91	Zahowski et al.	
	47	5,028,939	07/02/91	Hornbeck et al.	
	48	5,037,173	08/06/91	Sampsell et al.	
	49	5,044,736	09/03/91	Jaskie et al.	
	50	5,061,049	10/29/91	Hornbeck	
	51	5,075,796	12/24/91	Schildkraut et al.	
	52	5,078,479	01/07/92	Vuilleumier	
	53	5,079,544	01/07/92	DeMond et al.	
	54	5,083,857	01/28/92	Hornbeck	
	55	5,096,279	03/17/92	Hornbeck et al.	
	56	5,099,353	03/24/92	Hornbeck	

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Art Unit	2871
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	57	5,124,834	06/23/92	Cusano et al.	
	58	5,136,669	08/04/92	Gerd	
	59	5,142,405	08/25/92	Hornbeck	
	60	5,142,414	08/25/92	Koehler	
	61	5,153,771	10/06/92	Link et al.	
	62	5,162,787	11/10/92	Thompson et al.	
	63	5,168,406	12/01/92	Nelson	
	64	5,170,156	12/08/92	DeMond et al.	
	65	5,172,262	12/15/92	Hornbeck	
	66	5,179,274	01/12/93	Sampsell	
	67	5,192,395	03/09/93	Boysel et al.	
	68	5,192,946	03/09/93	Thompson et al.	
	69	5,206,629	04/27/93	DeMond et al.	
	70	5,212,582	05/18/1993	Nelson	
	71	5,214,419	05/25/93	DeMond et al.	
	72	5,214,420	05/25/93	Thompson et al.	
	73	5,216,537	06/01/93	Hornbeck	
	74	5,226,099	07/06/93	Mignardi et al.	
	75	5,228,013	07/13/93	Bik	
	76	5,231,532	07/27/93	Magel et al.	
	77	5,233,385	08/03/93	Sampsell	
	78	5,233,456	08/03/93	Nelson	
	79	5,233,459	08/03/93	Bozler et al.	
	80	5,254,980	10/19/93	Hendrix et al.	
	81	5,272,473	12/21/93	Thompson et al.	
	82	5,278,652	01/11/94	Urbanus et al.	
	83	5,280,277	01/18/94	Hornbeck	
	84	5,287,096	02/15/94	Thompson et al.	

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Art Unit	2871
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Attorney Docket No.	QCO.094A/061113

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	85	5,293,272	03-08-1994	Jannon, et al.	
	86	5,296,950	03/22/94	Lin et al.	
	87	5,299,041	03/29/94	Morin et al.	
	88	5,305,640	04/26/94	Boysel et al.	
	89	5,311,360	05/10/94	Bloom et al.	
	90	5,312,513	05/17/94	Florence et al.	
	91	5,323,002	06/21/94	Sampsell et al.	
	92	5,324,683	06/28/94	Fitch et al.	
	93	5,325,116	06/28/94	Sampsell	
	94	5,326,430	07/05/94	Cronin et al.	
	95	5,327,286	07/05/94	Sampsell et al.	
	96	5,330,617	07/19/1994	Michael Haond	
	97	5,331,454	07/19/94	Hornbeck	
	98	5,339,116	08/16/94	Urbanus et al.	
	99	5,345,328	09/06/94	Fritz et al.	
	100	5,347,377	09/13/1994	Revelli Jr. et al.	
	101	5,355,357	10/25/1994	Yamamori et al.	
	102	5,358,601	10/25/1994	Cathey	
	103	5,365,283	11/15/94	Doherty et al.	
	104	5,381,232	01/10/95	van Wijk	
	105	5,381,253	01/10/95	Sharp et al.	
	106	5,401,983	03/28/95	Jokerst et al.	
	107	5,411,769	05/02/95	Hornbeck	
	108	5,444,566	08/22/95	Gale et al.	
	109	5,446,479	08/29/95	Thompson et al.	
	110	5,448,314	09/05/95	Heimbuch et al.	
	111	5,452,024	09/19/95	Sampsell	
	112	5,454,906	10/03/95	Baker et al.	

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U.S. PATENT DOCUMENTS

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	113	5,457,493	10/10/95	Leddy et al.	
	114	5,457,566	10/10/95	Sampsell et al.	
	115	5,459,602	10/17/95	Sampsell	
	116	5,459,610	10/17/95	Bloom et al.	
	117	5,461,411	10/24/95	Florence et al.	
	118	5,474,865	12/12/1995	Vasudev	
	119	5,489,952	02/06/96	Gove et al.	
	120	5,497,172	03/05/96	Doherty et al.	
	121	5,497,197	03/05/96	Gove et al.	
	122	5,499,037	03/12/1996	Nakagawa et al.	
	123	5,499,062	03/12/96	Urbanus	
	124	5,500,635	03/19/96	Mott	
	125	5,500,761	03/19/96	Goossen et al.	
	126	5,503,952	04/02/96	Suzuki et al.	
	127	5,506,597	04/09/96	Thompson et al.	
	128	5,515,076	05/07/96	Thompson et al.	
	129	5,517,347	05/14/96	Sampsell	
	130	5,523,803	06/04/96	Urbanus et al.	
	131	5,526,051	06/11/96	Gove et al.	
	132	5,526,172	06/11/96	Kanack	
	133	5,526,327	06/11/96	Cordova, Jr.	
	134	5,526,688	06/18/96	Boysel et al.	
	135	5,535,047	07/09/96	Hornbeck	
	136	5,548,301	08/20/96	Kornher et al.	
	137	5,551,293	09/03/96	Boysel et al.	
	138	5,552,924	09/03/96	Tregilgas	
	139	5,552,925	09/03/96	Worley	
	140	5,559,358	09/24/96	Burns et al.	

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	141	5,563,398	10/08/96	Sampsell	
	142	5,567,334	10/22/96	Baker et al.	
	143	5,570,135	10/29/96	Gove et al.	
	144	5,579,149	11/26/96	Moret et al.	
	145	5,581,272	12/03/96	Conner et al.	
	146	5,583,688	12/10/96	Hornbeck	
	147	5,589,852	12/31/96	Thompson et al.	
	148	5,597,736	01/28/97	Sampsell	
	149	5,600,383	02/04/97	Hornbeck	
	150	5,602,671	02/11/97	Hornbeck	
	151	5,606,441	02/25/97	Florence et al.	
	152	5,608,468	03/04/97	Gove et al.	
	153	5,610,438	03/11/97	Wallace et al.	
	154	5,610,624	03/11/97	Bhuva	
	155	5,610,625	03/11/97	Sampsell	
	156	5,619,059	04/08/97	Li et al.	
	157	5,619,365	04/08/97	Rhoades et al.	
	158	5,619,366	04/08/97	Rhoads et al.	
	159	5,622,814	04/22/97	Miyata et al.	
	160	5,629,790	05/13/97	Neukermans et al.	
	161	5,633,652	05/27/97	Kanbe et al.	
	162	5,636,052	06/03/97	Arney et al.	
	163	5,636,185	06/03/97	Brewer et al.	
	164	5,638,084	06/10/97	Kalt	
	165	5,638,946	06/17/97	Zavracky	
	166	5,641,391	06/24/97	Hunter et al.	
	167	5,646,768	07/08/97	Kaeiyama	
	168	5,647,819	07/15/1997	Fujita, et al.	

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	169	5,650,834	07/22/1997	Nakagawa et al.	
	170	5,650,881	07/22/97	Hornbeck	
	171	5,654,741	08/05/97	Sampsell et al.	
	172	5,657,099	08/12/97	Doherty et al.	
	173	5,659,374	08/19/97	Gale, Jr. et al.	
	174	5,665,997	09/09/97	Weaver et al.	
	175	5,673,139	09/30/97	Johnson	
	176	5,674,757	10/07/97	Kim	
	177	5,683,591	11/04/97	Offenberg	
	178	5,703,710	12/30/97	Brinkman et al.	
	179	5,706,022	01/06/98	Hato	
	180	5,710,656	01/20/98	Goosen	
	181	5,726,480	03/10/98	Pister	
	182	5,739,945	04/14/98	Tayebati	
	183	5,745,193	04/28/98	Urbanus et al.	
	184	5,745,281	04/28/98	Yi et al.	
	185	5,771,116	06/23/98	Miller et al.	
	186	5,784,190	07/21/98	Worley	
	187	5,784,212	07/21/98	Hornbeck	
	188	5,793,504	08/11/98	Stoll	
	189	5,808,780	09/15/98	McDonald	
	190	5,818,095	10/06/98	Sampsell	
	191	5,822,170	10/13/1998	Cabuz et al.	
	192	5,824,608	10/20/1998	Gotoch, et al.	
	193	5,825,528	10/20/98	Goosen	
	194	5,835,255	11/10/98	Miles	
	195	5,838,484	11/17/1998	Gossen et al.	
	196	5,842,088	11/24/98	Thompson	

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	197	5,867,302	02/02/1999	Fleming et al.	
	198	5,912,758	06/15/99	Knipe et al.	
	199	5,943,158	08/24/99	Ford et al.	
	200	5,959,763	09/28/99	Bozler et al.	
	201	5,972,193	10/26/99	Chou et al.	
	202	5,976,902	11/02/99	Shih	
	203	5,986,796	11/16/99	Miles et al.	
	204	6,016,693	01/25/2000	Viani et al.	
	205	6,028,690	02/22/00	Carter et al.	
	206	6,038,056	03/14/00	Florence et al.	
	207	6,040,937	03/21/00	Miles	
	208	6,049,317	04/11/00	Thompson et al.	
	209	6,055,090	4/25/2000	Miles et al.	
	210	6,057,903	05/02/2000	Colgan et al.	
	211	6,061,075	05/09/00	Nelson et al.	
	212	6,099,132	08/08/00	Kaeriyama	
	213	6,100,872	08/08/00	Aratani et al.	
	214	6,113,239	09/05/00	Sampsel et al.	
	215	6,115,326	09/05/2000	Puma et al.	
	216	6,158,156	12/12/2000	Patrick, David	
	217	6,147,790	11/14/00	Meier et al.	
	218	6,160,833	12/12/00	Floyd et al.	
	219	6,166,422	12/26/2000	Qian et al.	
	220	6,180,428	01/30/01	Peeters et al.	
	221	6,194,323	02/27/2001	Downey et al.	
	222	6,195,196	02/27/01	Kimura et al.	
	223	6,201,633	03/13/01	Peeters et al.	
	224	6,204,080	03/20/2001	Hwang	

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	225	6,232,936	05/15/01	Gove et al.	
	226	6,243,149	06/05/01	Swanson et al.	
	227	6,246,398	06/12/2001	Koo	
	228	6,249,039	06/19/2001	Harvey et al.	
	229	6,282,010	08/28/01	Sulzbach et al.	
	230	6,284,560	09-04-2001	Jech, et al.	
	231	6,295,154	09/25/01	Laor et al.	
	232	6,323,982	11/27/01	Hornbeck	
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	235	6,335,831	01/01/2002	Kowarz et al.	
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	237	6,356,254	03/12/02	Kimura, Koichi	
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*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Application No.	10/815,905
	Filing Date	March 31, 2004
	First Named Inventor	Lin, et al.
	Art Unit	2871
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Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	253	6,522,801	02/18/2003	Aksyuk et al.	
	254	6,531,945	03/11/2003	Ahn et al.	
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	256	6,548,908	04/15/03	Chua et al.	
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	259	6,574,033	06/03/03	Chen et al.	
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	261	6,589,625	07/08/03	Kothari et al.	
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	270	6,642,913	11/04/2003	Kimura et al.	
	271	6,643,069	11/04/03	Dewald	
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Application No.	10/815,905
	Filing Date	March 31, 2004
	First Named Inventor	Lin, et al.
	Art Unit	2871
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Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	281	6,736,987	05-18-2004	CHO	
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	290	6,775,174	08/10/04	Huffman et al.	
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<p>*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>	

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Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
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	322	2001-0040675	11-15-2001	True, et al.	
	323	2002-0015215	02/07/02	Miles	
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	326	2002-0036304	03/28/2002	Ehmke et al.	
	327	2002-0054424	5/9/2002	Miles	
	328	2002/055253	05/09/02	Rudhard	
	329	2002-0071169	06/13/2002	Bowers et al.	
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	332	2002-0126364	09/12/02	Miles	
	333	2002/137072	09/26/02	Mirkin et al.	
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Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	337	2003-0006468	01/09/2003	Ma et al.	
	338	2003-0043157	03/06/2003	Miles	
	339	2003-0054588	03/20/2003	Patel, et al.	
	340	2003-0062186	04/03/2003	Boroson et al.	
	341	2003-0072070	04/17/2003	Miles	
	342	2003-0090350	05/15/2003	Feng et al.	
	343	2003-0112096	06/19/2003	Potter	
	344	2003-0138213	07/24/2003	Jiin et al.	
	345	2003-0152872	08/14/2003	Miles, Mark W.	
	346	2003-0201784	10/30/2003	Potter	
	347	2003-0202264	10/30/2003	Weber et al.	
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	351	2004-0010115	01-15-2004	Sotzing	
	352	2004-0028849	02-12-2004	Stark et al.	
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	354	2004-0027701	02-12-2004	Ishikawa	
	355	2004-0035821	02-26-2004	Doan et al.	
	356	2004-0051929	03-18-2004	Sampsel et al.	
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	358	2004-0058532	03-25-2004	Miles et al.	
	359	2004-0058531	03-25-2004	Miles et al.	
	360	2004-0061543	04-01-2004	Nam et al.	
	361	2004-0063322	04-01-2004	Yang	
	362	2004-0080807	04-29-2004	Chen et al.	
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Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
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	369	2004-0125536	07-01-2004	Arney et al.	
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	371	2004-0148009	07-29-2004	Buzzard	
	372	20040145049	07-29-2004	McKinnell et al.	
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	374	2004-0145811	07-29-2004	Lin, et al.	
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	376	2004-0150869	08-05-2004	Kasai, Hiroto	
	377	2004-0160143	08-19-2004	Shreeve et al.	
	378	20040174583	09/09/04	Chen et al.	
	379	2004/0175577	09/09/04	Lin et al.	
	380	2004-0179445	09/16/2004	Park	
	381	20040179281	09/16/04	Reboa	
	382	2004/0191937	09/30/04	Patel et al.	
	383	2004/0207897	10/21/04	Lin	
	384	2004/0209192	10/21/04	Lin et al.	
	385	2004/0209195	10/21/04	Lin	
	386	20040212026	10/28/04	Van Brocklin et al.	
	387	20040217378	11/04/04	Martin et al.	
	388	20040217919	11/04/04	Pichl et al.	
	389	20040218251	11/04/04	Piehl et al.	
	390	20040218334	11/04/04	Martin et al.	
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Application No.	10/815,905
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	393	2004/0240027	12/02/04	Lin et al.	
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	397	20040263944	12/30/04	Miles et al.	
	398	20050001828	01/06/05	Martin et al.	
	399	2005/0003667	01/06/05	Lin et al.	
	400	2005/0020089	01/27/05	Shi et al.	
	401	2005/0024557	02/03/05	Lin	
	402	2005/0035699	02/17/05	Tsai	
	403	2005/0036095	02/17/05	Yeh et al.	
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	406	2005/0042117	02/24/05	Lin	
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	411	20050069209	03/31/05	Damera-Venkata et al.	
	412	2005/0068605	03/31/05	Tsai	
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Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T ¹
	420	CH 681 047	12-31-1992	Landis & GYR Betriebs		
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	429	EP 0 667 548 A1	08-16-1995	AT&T Corporation		
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	435	JP 11243214	09/07/1999	Nippon Telegr & Teleph	Abstract Only	
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	437	JP 2002-270575	09/02/2002	Seiko Epson Corp.		
	438	JP 2002-355800	12/10/2002	Samsung Electronics	Abstract Only	
	439	JP 2004-102022A	04/02/2004	Ricoh Co. Ltd.	Abstract Only	
	440	JP 2004-212656	07/29/2004	Fuji Photo Film	Abstract Only	
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	442	JP 2002 062493	2/28/2002	Canon Inc.		
	443	JP 2004106074 A	4/8/2004	Sony Corp		
	444	JP 2003-001598	01-08-2003	Sony Corp		
	445	JP 2005-051007	02-24-2005	Tokyo Electric		
	446	KR 2000-0033006	06/15/2000	Moon et al.		
	447	KR 2002-9270	10/23/1999			
	448	RCO Pt Pub 157313	05/01/1991	FSI International		
	449	WO 01/14248	03/01/2001	Knowles Electronics		

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Application No.	10/815,905
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Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T ¹
	450	WO 03/052506	06/26/2003	Nokia Corporation		
	451	WO 05/085932A	09/15/2005	Kothari et al.		
	452	WO 06/036385	04/06/2006	IDC, LLC		
	453	WO 06/036437	04/06/2006	IDC, LLC		
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	455	WO 92/10925	06/25/1992	Robert Bosch GmBh		
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	459	WO 03/007049A1	01-23-2003	Iridigm Display Corp.		
	460	WO03073151A1	09-04-2003	Iridigm Display Corp.		
	461	WO04006003A1	01-15-2004	Iridigm Display Corp.		
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	463	WO9530924	11-16-1995	Etalon, Inc.		
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NON PATENT LITERATURE DOCUMENTS

Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ¹
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NON PATENT LITERATURE DOCUMENTS

Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ¹
	472	Austrian Search Report for EX81/2005 dated May 18, 2005.	
	473	Austrian Search Report for EX170/2005 dated July 6, 2005.	
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